


<b>Search Notes</b> 	<b>Application/Control No.</b> 10771727	<b>Applicant(s)/Patent Under Reexamination</b> HAYASHI, HIDEYUKI
	<b>Examiner</b> Quiett, Carramah J	<b>Art Unit</b> 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	14.02, 14.12, 207.99, 207.1, 211.6, 211.2, 231.2, 231.3, 231.6, 231.9	8/21/2007	cjq

SEARCH NOTES		
Search Notes	Date	Examiner
Keyword Search with/without class/subclasses	8/30/2007	cjq
See Search History	8/30/2007	cjq

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner